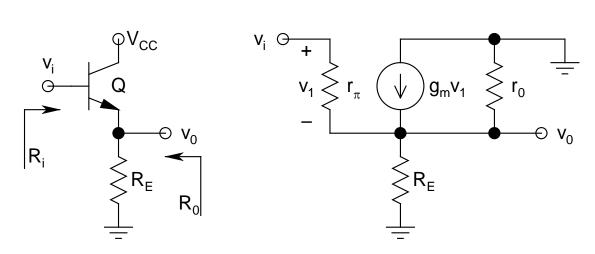
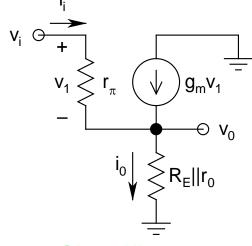
- Common-Collector (CC):
  - > Also known as *Emitter-Follower*





ac Schematic

ac Low-Frequency Equivalent

Simplified ac Low-Frequency Equivalent

> Biasing circuit not shown

## > Voltage Gain:

$$A_{v} = \frac{v_{0}}{v_{i}} = \frac{i_{0}(R_{E} || r_{0})}{v_{1} + v_{0}} = \frac{(\beta + 1)i_{i}(R_{E} || r_{0})}{i_{i}r_{\pi} + (\beta + 1)i_{i}(R_{E} || r_{0})}$$
$$= \frac{R_{E} || r_{0}}{r_{\pi}/(\beta + 1) + R_{E} || r_{0}} = \frac{R_{E} || r_{0}}{r_{E} + R_{E} || r_{0}}$$

 $\triangleright$  Now, in general,  $r_0 >> R_E$ 

$$\Rightarrow$$
  $A_v = R_E/(r_E + R_E)$ 

- > Two important observations:
  - $\blacksquare A_v \leq 1$
  - No phase shift between  $v_i$  and  $v_0$

## > Current Gain:

$$A_i = i_e/i_b = \beta + 1$$
 (*large*)

## > Input Resistance:

$$R_{i} = \frac{v_{i}}{i_{i}} = \frac{i_{i}r_{\pi} + i_{0}(R_{E} || r_{0})}{i_{i}}$$

$$= \frac{i_{i}r_{\pi} + (\beta + 1)i_{i}(R_{E} || r_{0})}{i_{i}}$$

$$= r_{\pi} + (\beta + 1)(R_{E} || r_{0})$$

■ If 
$$r_0 >> R_E$$
,  $R_i = r_\pi + (\beta + 1)R_E$ 

Note that this result could have been written from inspection from the ac schematic using the technique of Resistance Transformation

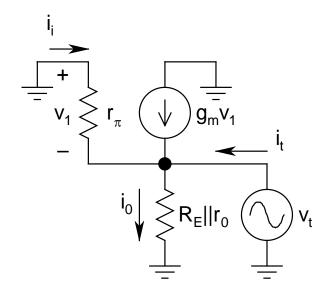
## > Output Resistance:

$$i_{t} = i_{0} - g_{m} v_{1} - i_{i}$$

$$= \frac{v_{t}}{R_{E} || r_{0}} + g_{m} v_{t} + \frac{v_{t}}{r_{\pi}}$$

$$\Rightarrow R_0 = R_E ||r_0||r_E||r_\pi \approx r_E$$

Note that this expression also could have been written by inspection



- $\triangleright$  Output excited by a test voltage source  $v_t$ :
  - The current has two parallel paths: one going through the parallel combination of  $r_0$  and  $R_E$ , and the other into the emitter of Q
  - The resistance in the base lead of Q is  $r_{\pi}$ , which needs to be transformed to emitter by dividing it by  $(\beta+1) \Rightarrow yields r_{E}$
  - Thus,  $R_0$  becomes a parallel combination of  $r_0$ ,  $R_E$ , and  $r_E$ , which will be typically equal to  $r_E$ , since, in general, it's the least among the three
- > Understand the inspection technique, it will become immensely useful to analyze circuits